

FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO.
8046-1010

SERIAL NO.
09/934,840

**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**

(Use separate sheets if necessary)

37 CFR 1.98(b)

APPLICANT
Yoshitaka FUJITA

FILING DATE
August 23, 2001

GROUP
2162

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		ISSUE DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA					
	AB					
	AC					
	AD					
	AE					
	AF					
	AG					

FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION

		DOCUMENT NO.	PUBL. DATE	COUNTRY OR PATENT OFFICE	CLASS	SUB CLASS	TRANSLATION YES NO
DJR	AJ	2000-32128	1/00	Japan			X
DJR	AK	11-355461	12/99	Japan			X
	AL						
	AM						
	AN						

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JUL 29 2003
GROUP 3600

OTHER DOCUMENTS (Including Author, Title, Date, Relevant Pages, Place of Publication)

	AO	
	AP	
	AQ	

EXAMINER *Daniel Byman*

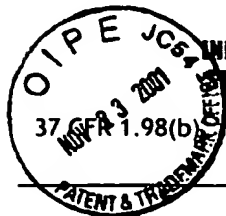
DATE CONSIDERED *12 April 2005*

EXAMINER: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO.
FQ5-561

SERIAL NO.
09/934,840



**INFORMATION DISCLOSURE
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(Use several sheets if necessary)

APPLICANT
Yoshitaka FUJITA

FILING DATE
August 23, 2001

GROUP
2162

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		PATENT NUMBER	ISSUE DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						

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NOV 26 2001
Technology Center 2100

FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION

		DOCUMENT NO.	PUBL. DATE	COUNTRY OR PATENT OFFICE	CLASS	SUB CLASS	TRANSLATION YES NO
1012	AJ	10-322399	12-98	JAPAN (W/ABSTRACT)			
	AK						
	AL						
	AM						
	AN						

OTHER DOCUMENTS (Including Author, Title, Date, Relevant Pages, Place of Publication)

	AO	
EXAMINER <i>Demetri Byman</i>	DATE CONSIDERED <i>12 April 2005</i>	

EXAMINER: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.